



P-Channel 20 V (D-S) MOSFET with Schottky Diode

MOSFET PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)			
	0.104 at V _{GS} = - 4.5 V	- 4 ^a				
- 20	0.144 at V _{GS} = - 2.5 V	- 3.6	4.2 nC			
	0.205 at V _{GS} = - 1.8 V	- 3				

SCHOTTKY PRODUCT SUMMARY				
V _{KA} (V)	V _f (V) Diode Forward Voltage	I _F (A)		
20	0.46 at 0.5 A	1		

1206-8 ChipFET

Marking Code Lot Traceability and Date Code Part # Code **Bottom View**

Ordering Information: Si5853CDC-T1-E3 (Lead (Pb)-free) Si5853CDC-T1-GE3 (Lead (Pb)-free and Halogen-free)

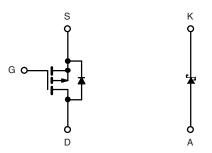
FEATURES

- Halogen-free According to IEC 61249-2-21 **Definition**
- LITTLE FOOT® Plus Schottky Power MOSFET
- Compliant to RoHS Directive 2002/95/EC

COMPLIANT **FREE**

APPLICATIONS

- Charging Switch for Portable Devices
- With Integrated Low V_f Trench Schottky Diode



P-Channel MOSFET

Parameter	Symbol	Limit	Unit	
Drain-Source Voltage (MOSFET)	V _{DS}	- 20		
Reverse Voltage (Schottky)		V _{KA}	20	V
Gate-Source Voltage (MOSFET)	V _{GS}	± 8		
	T _C = 25 °C		- 4 ^a	
Continuous Drain Current /T 150 °C\ (MOSEFT)	T _C = 70 °C		- 3.4 ^a	
Continuous Drain Current (T _J = 150 °C) (MOSFET)	T _A = 25 °C	I _D	- 2.9 ^{b, c}	
	T _A = 70 °C		- 2.3 ^{b, c}	
Pulsed Drain Current (MOSFET)	1	I _{DM}	- 10	Α
Outliness Outlines (MOOFFT Binds Outline)	T _C = 25 °C	1	- 2.6	
Continuous Source Current (MOSFET Diode Conduction)	T _A = 25 °C	I _S	- 1.2 ^{b, c}	
Average Forward Current (Schottky)		I _F	1	
Pulsed Forward Current (Schottky)	I _{FM}	3		
	T _C = 25 °C		3.1	
Maximum Dawar Dissipation (MOSEET)	T _C = 70 °C		2	
Maximum Power Dissipation (MOSFET)	T _A = 25 °C		1.5 ^{b, c}	
	T _A = 70 °C	В	0.9 ^{b, c}	١٨/
	T _C = 25 °C	P _D	2.5	W
Marrian and Danier Discipation (Calcattler)	T _C = 70 °C		1.6	
Maximum Power Dissipation (Schottky)	T _A = 25 °C		1.2	
	T _A = 70 °C		0.76	
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C	
Soldering Recommendation (Peak Temperature) ^{d, e}		260		

Si5853CDC

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THERMAL RESISTANCE RATINGS							
Parameter	Symbol	Typical	Maximum	Unit			
Maximum Junction-to-Ambient (MOSFET) ^{b, c, f}	R _{thJA}	70	85				
Maximum Junction-to-Foot (Drain) (MOSFET)	R _{thJF}	33	40	°C/W			
Maximum Junction-to-Ambient (Schottky) ^{b, c, g}	R _{thJA}	85	105	O/VV			
Maximum Junction-to-Foot (Drain) (Schottky)	R _{thJF}	40	50				

Notes:

- a. Package limited.
- b. Surface mounted on FR4 board.
- c. t ≤ 5 s
- d. See Solder Profile (www.vishay.com/doc?73257). The ChipFET is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions for MOSFETs is 120 °C/W.
- g. Maximum under steady state conditions for Schottky is 125 °C/W.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static			1			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_D = -250 \mu\text{A}$	- 20			V
V _{DS} Temperature Coefficient	$\Delta V_{DS/TJ}$	I _D = - 250 μA		- 20		m\//°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)/TJ}$	I _D = - 250 μA		2.1		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.45		- 1	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA
Zava Cata Valtaga Dvain Current	1	V _{DS} = - 20 V, V _{GS} = 0 V			- 1	μΑ
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 20 V, V _{GS} = 0 V, T _J = 85 °C			- 10	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 10			Α
Drain-Source On-State Resistance ^a		$V_{GS} = -4.5 \text{ V}, I_D = -2.5 \text{ A}$		0.086	0.104	4 Ω
	R _{DS(on)}	$V_{GS} = -2.5 \text{ V}, I_D = -2.1 \text{ A}$		0.120	0.144	
		V _{GS} = - 1.8 V, I _D = - 0.5 A		0.170	0.205	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 2.5 A		6		S
Dynamic ^b	<u> </u>		•	I.	,	
Input Capacitance	C _{iss}	V _{DS} = - 10 V, V _{GS} = 0 V, f = 1 MHz		350		pF
Output Capacitance	C _{oss}			65		
Reverse Transfer Capacitance	C _{rss}			45		
Total Cata Charge	Qg	$V_{DS} = -10 \text{ V}, V_{GS} = -8 \text{ V}, I_{D} = -2.9 \text{ A}$		7.2	11	nC
Total Gate Charge				4.2	6.5	
Gate-Source Charge	Q_{gs}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -2.9 \text{ A}$		0.7		
Gate-Drain Charge	Q_{gd}			1		
Gate Resistance	R_g	f = 1 MHz		6.2		Ω
Turn-On Delay Time	t _{d(on)}			15	25	
Rise Time	t _r	V_{DD} = - 10 V, R_L = 4.4 Ω		42	65	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 2.3 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		20	30	
Fall Time	t _f			10	15	
Turn-On Delay Time	t _{d(on)}			5	10	ns
Rise Time	t _r	V_{DD} = - 10 V, R_L = 4.4 Ω		15	25	1
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 2.3 A, V_{GEN} = - 8 V, R_g = 1 Ω		20	30	
Fall Time	t _f			10	15]





SPECIFICATIONS T _J = 25 °C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Drain-Source Body Diode Characteristics							
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 2.6	۸	
Pulse Diode Forward Current	I _{SM}				- 10	Α	
Body Diode Voltage	V _{SD}	I _S = - 2.3 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			20	40	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = - 2.3 A dl/dt = 100 A/μs T _{.I} = 25 °C		15	30	nC	
Reverse Recovery Fall Time	t _a	1 1 = -2.5 A αι/αι = 100 A/μ5 1 J = 25 C		16		no	
Reverse Recovery Rise Time	t _b			4		ns	

Notes:

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.

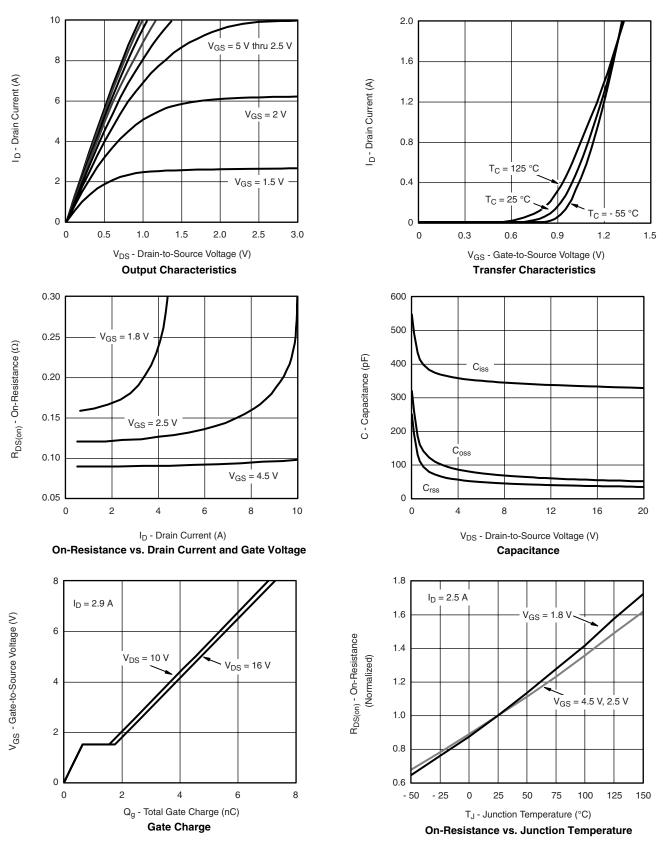
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Forward Voltage Drop	V _F	I _F = 0.5 A		0.381	0.46	V
		I _F = 1 A		0.468	0.560	
		I _F = 1 A, T _J = 125 °C		0.44	0.53	
	I _{rm}	V _r = 5 V		0.0081	0.080	mA
		V _r = 5 V, T _J = 85 °C		0.4	4	
Maximum Dayaraa Laaka aa Current		V _r = 5 V, T _J = 125 °C		2.8	28	
Maximum Reverse Leakage Current		V _r = 20 V		0.0093	0.09	
		$V_r = 20 \text{ V}, T_J = 85 ^{\circ}\text{C}$		0.45	4.5	
		V _r = 20 V, T _J = 125 °C		3.2	32	
Junction Capacitance	C _T	V _r = 10 V		30		pF

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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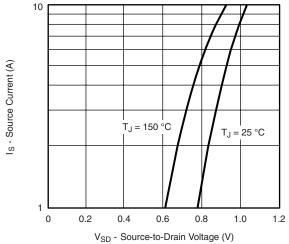
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MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

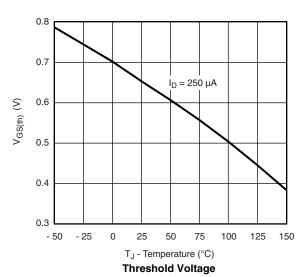


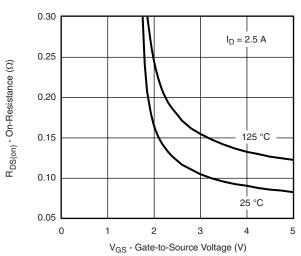


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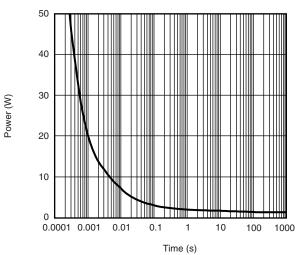


Source-Drain Diode Forward Voltage

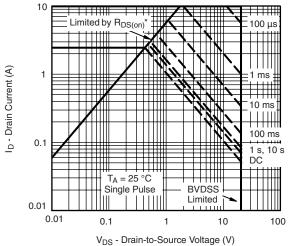




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient



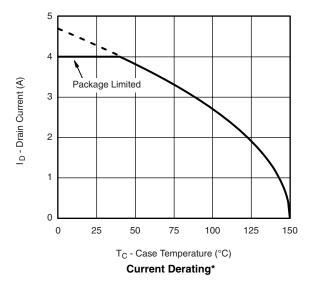
 v_{DS} - Drain-to-Source voltage (v) * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified Safe Operating Area, Junction-to-Ambient

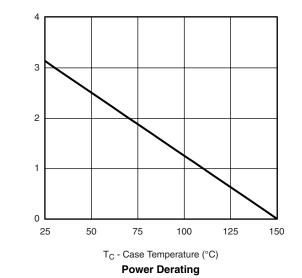
Document Number: 69774 S10-0547-Rev. B, 08-Mar-10

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MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



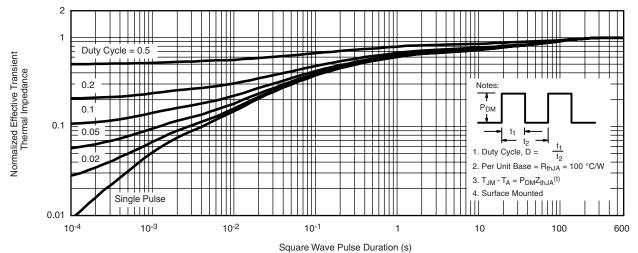


Power Dissipation (W)

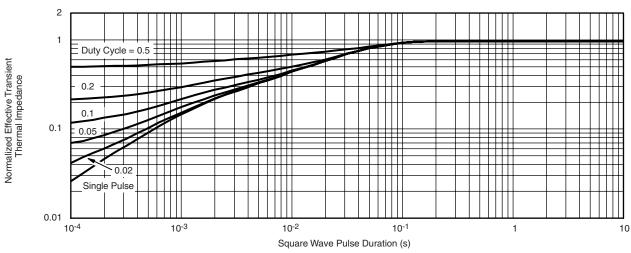
 $^{^{\}star}$ The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient

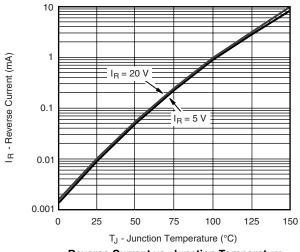


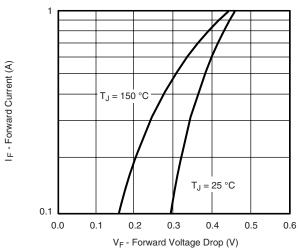
Normalized Thermal Transient Impedance, Junction-to-Foot

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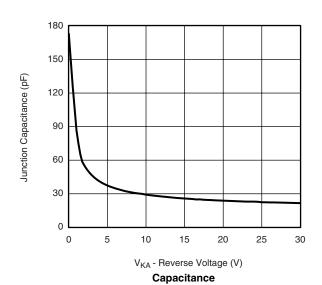
SCHOTTKY TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





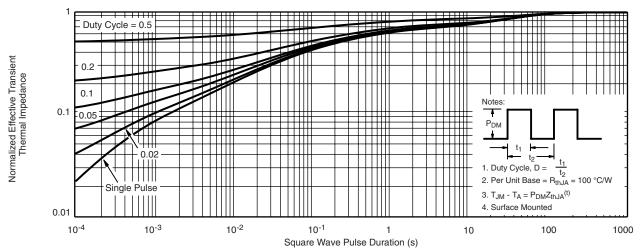
Reverse Current vs. Junction Temperature

Forward Voltage Drop

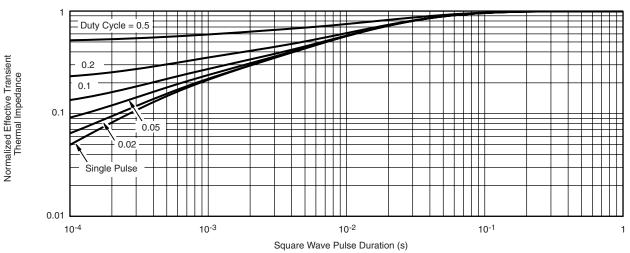




SCHOTTKY TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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